

<b>Notice of References Cited</b>	Application/Control No. 10/520,300		Applicant(s)/Patent Under Reexamination EWERT ET AL.	
	Examiner Charles N. Appiah		Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,945,919	08-1999	Trask, Matthew M.	340/825.49
*	B	US-2003/0020637	01-2003	Ricard, Claude	340/988
*	C	US-6,526,275	02-2003	Calvert, Brian Edward	455/418
*	D	US-6,615,046	09-2003	Ur, Shmuel	455/445
*	E	US-2003/0054837	03-2003	Ennis, Mark Kieran	455/456
*	F	US-6,756,913	06-2004	Ayed, Mourad Ben	340/825.49
*	G	US-2004/0177109	09-2004	Lee, Jae-Wook	709/201
*	H	US-7,050,818	05-2006	Tendler, Robert K.	455/456.2
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.